

# Groupe ILC LAL

## Physiciens : Roman POESCHL

François RICHARD , Thibault FRISSON , Jérémie ROUENNE, Amjad SOHAIL

Omega

Nathalie SEGUIN MOREAU  
Stéphane CALLIER  
Ludovic RAUX

**SDTM:**

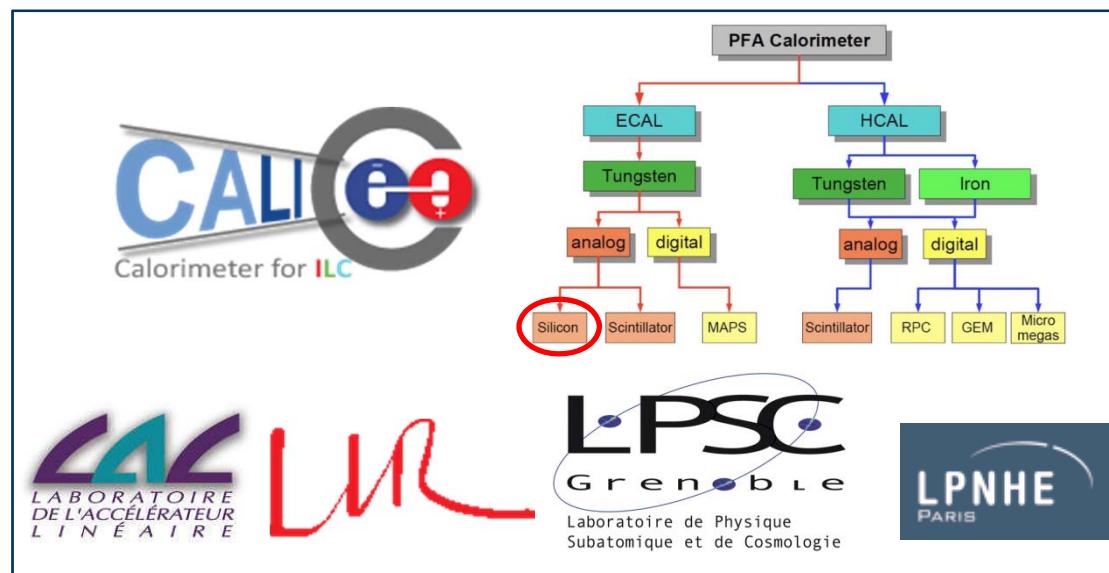
Julien BONIS  
Christian BOURGEOIS  
Alexandre GONNIN



**Patrick CORNEBISE**

**Dominique CUISY**

François WICEK  
Pascal RUSQUART  
Christophe HERNANDEZ  
Jean-Luc SOCHA  
Michel GASPARD  
Stéphane TROCHET  
Marc FERNANDEZ





ILC (International Linear Collider)

Etudes de la physique et du développement d'un détecteur à opérer au sein du futur collisionneur linéaire d'électrons et positrons .

Cette machine permettra d'explorer la physique aux énergies d'environ 1 TeV .



31 kms de long

2 détecteurs: SID et ILD positionnés alternativement sur la ligne ILC

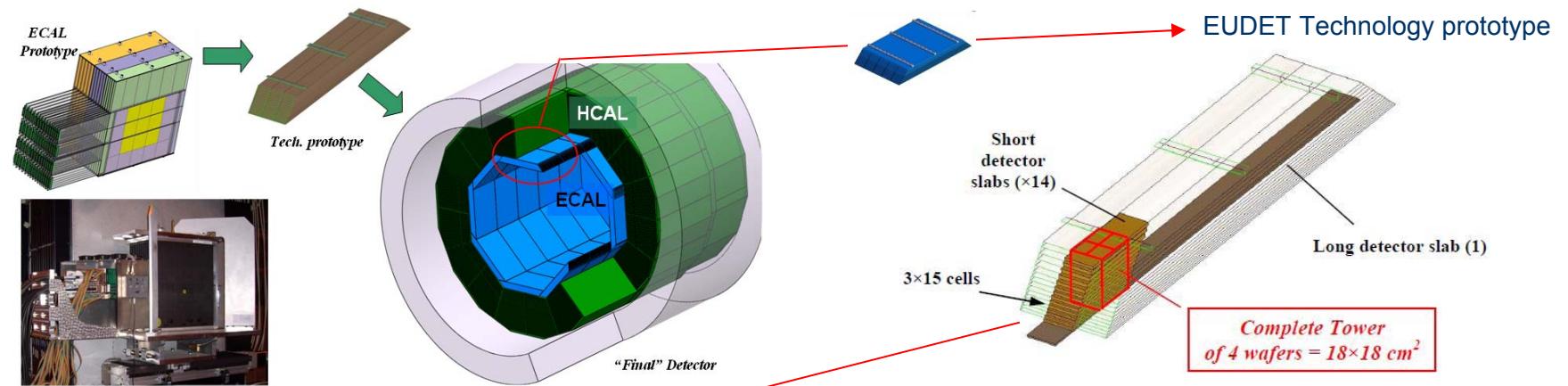
**ILD**

Poids: 12 kton  
Hauteur: 15,50 mètres  
Longueur: 13,40 mètres

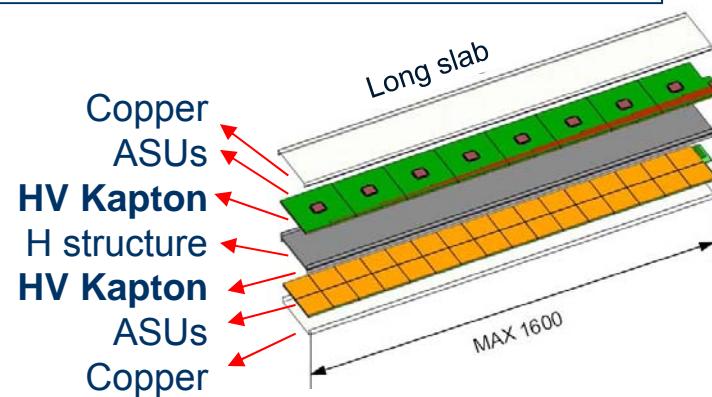
VTX Vertex  
SIT Silicium Inner Tracking  
FTD Forward Tracking Disk  
SET Silicium External Tracking  
**TPC Time Projection Chamber**  
HCal Hadronique Calorimeter  
**ECal**  
**Electromagnétique Calorimeter**  
**5 roues de 8 modules**  
**150 alvéoles/module**

1 Module ECal Barrel

# The goal is realize interconnection of ASUs for EUDET Technology prototype

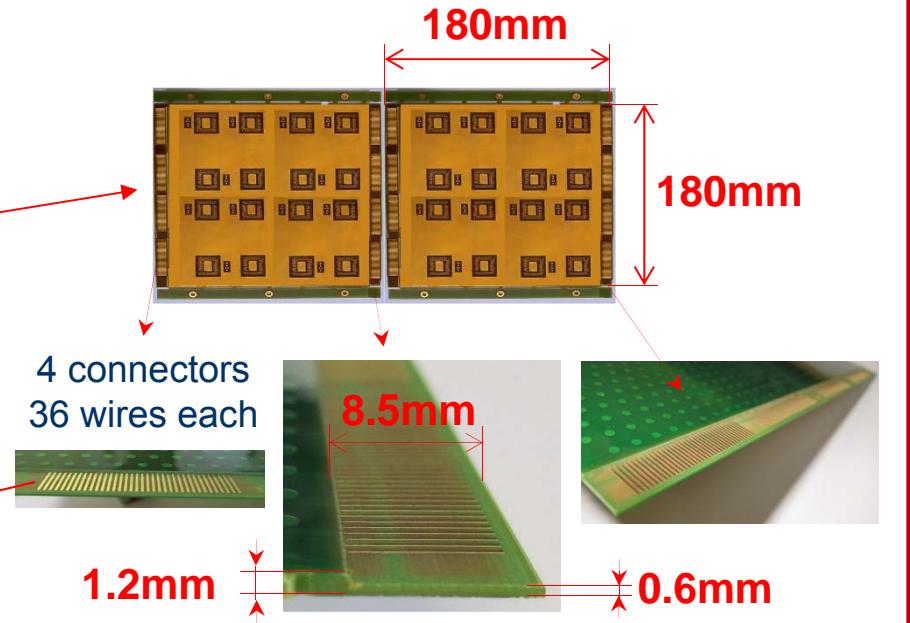


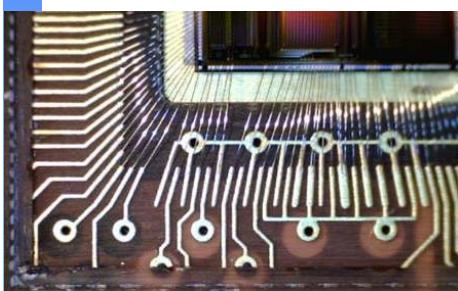
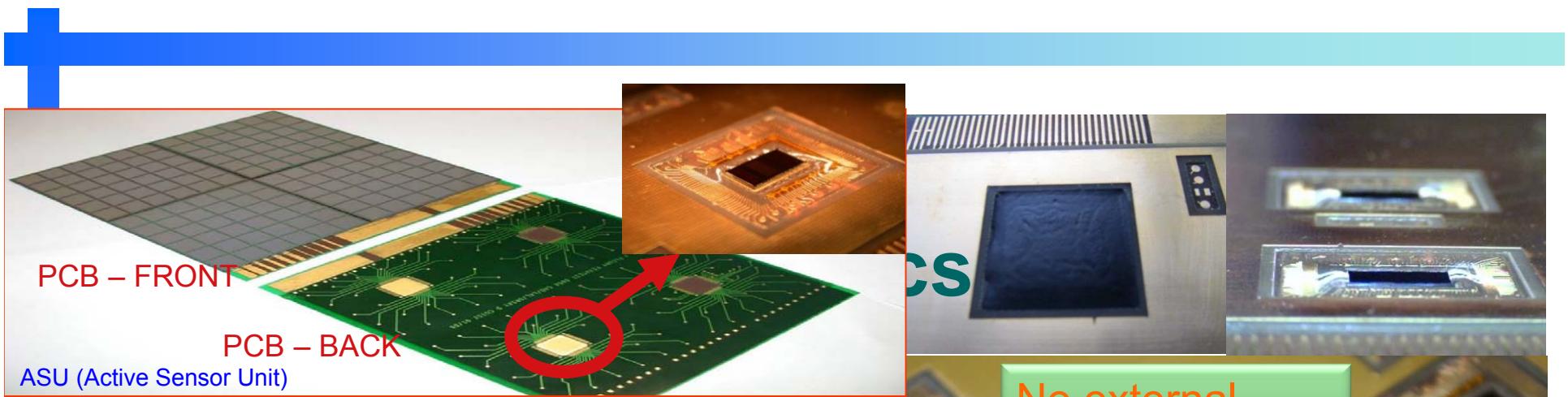
**1x Long slab with:**  
7 ASUs+1Adapter-card+1Dif each side  
**14x Short slab with:**  
1ASU+1Adapter-card+1Dif each side  
Will be interconnected



Total ILD: Barrel 336 000 connecteurs 36 voies

This presentation focuses on the ASUs interconnections study





E-CAL Constraints for FE:

Thickness ( $>1.2\text{mm}$ )

Flatness ( $325\mu\text{m}$  Si wafer on bottom)

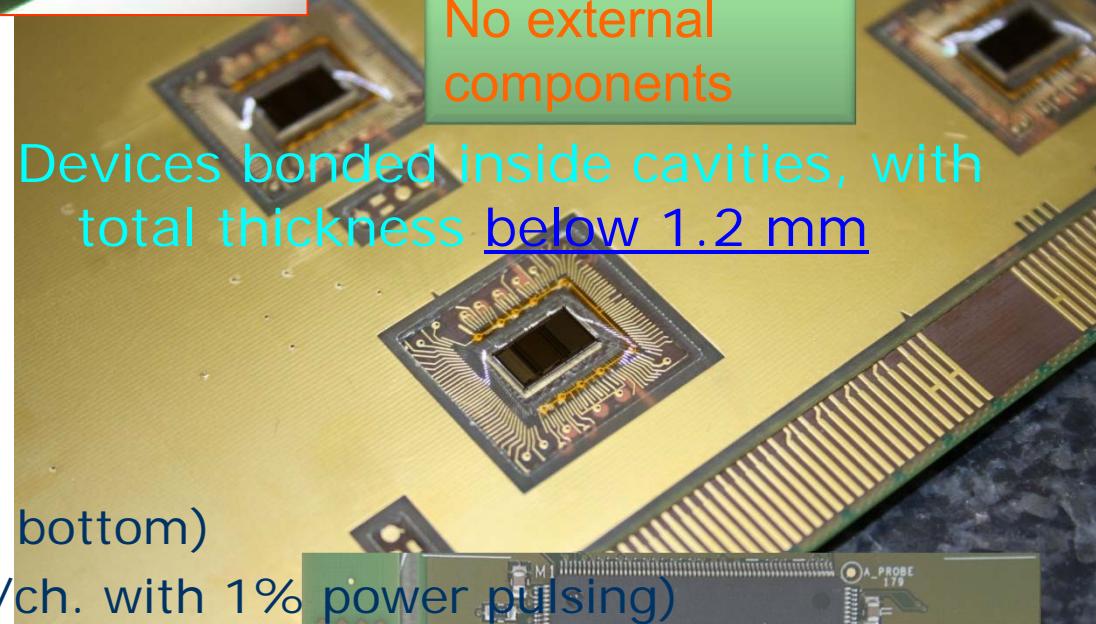
Power consumption ( $>25\mu\text{W}/\text{ch.}$  with 1% power pulsing)

Low noise (1MIP = 4fC)

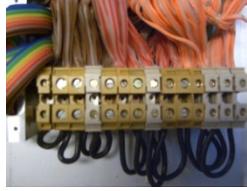
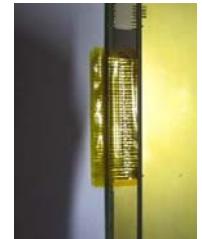
Auto Trigger

ADC Embedding

Zero suppress



Currently in test Beam @ DESY :  
Backup solution using Packaged SKIROC2

Patch pannel	HV kapton	Interconnection By solder paste	Interconnection By ACF	Interconnection By Kapton	Manipulator 3 axis
					
	J.L Socha		P.Rusquart,C.Hernandez,S.Trochet		

Test réseau Bragg (fibres opt) sur la nouvelle structure alvéolaire à l'institut sup optique Palaiseau



ECAL prototype physique  
Fermilab test beam



Thermal slab LAL Test  
M.Gaspard

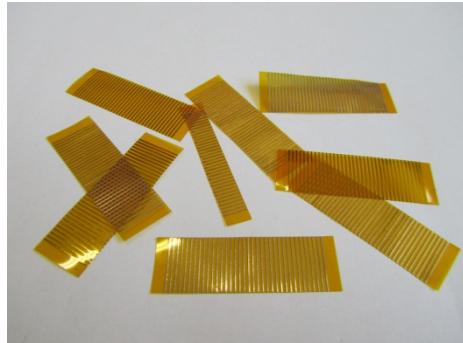


Ecal with DHCAL  
Fermilab test beam

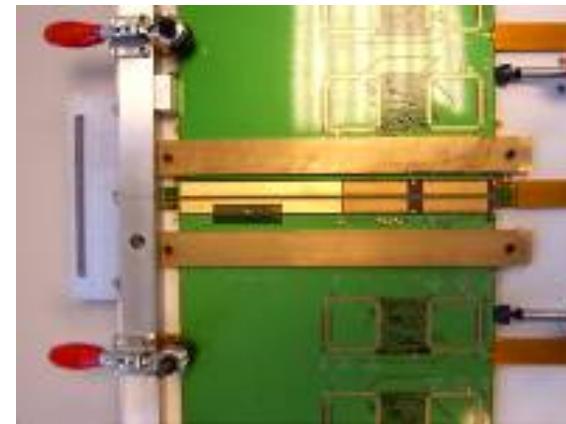


FEV8 Desy  
test beam

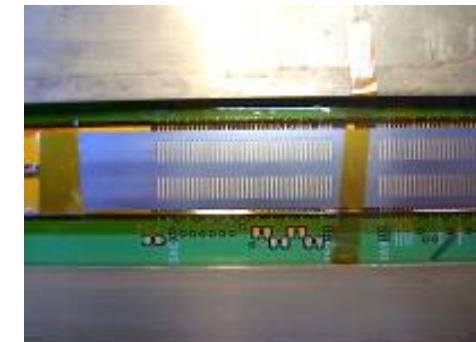
# ASU interconnection by soldering



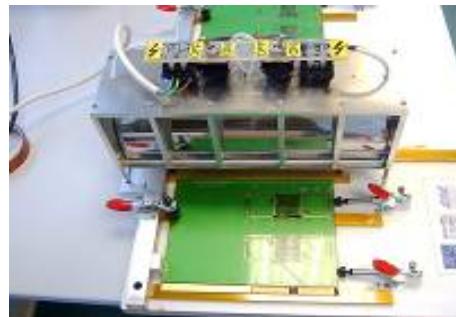
Kapton comb 1 connector  
with 36 wires



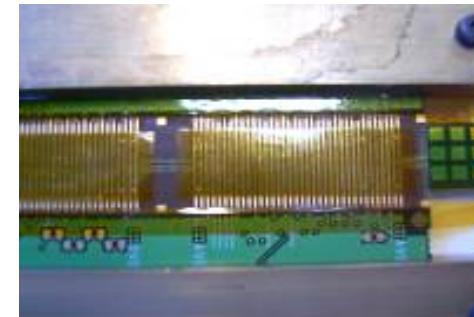
Solder bench



Silk screen for  
manual solder paste laying  
(very delicate operation)



Halogen lamp for the solder  
200°C for 2min 30sec



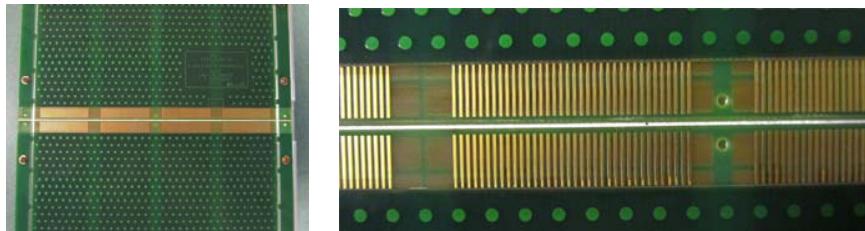
We developed this method with the  
and used it to interconnect 8 FEV-temps



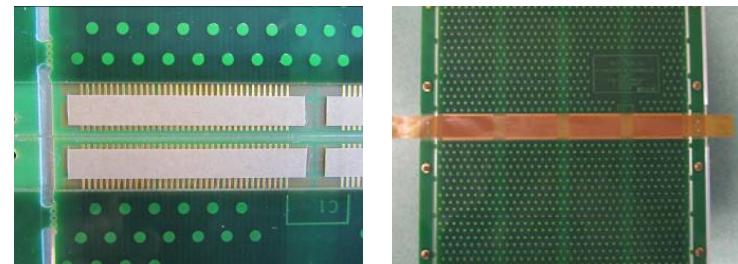
UNIVERSITY OF  
CAMBRIDGE

# ASU interconnection with ACF **3M** Anisotropic Conductive Film adhesives

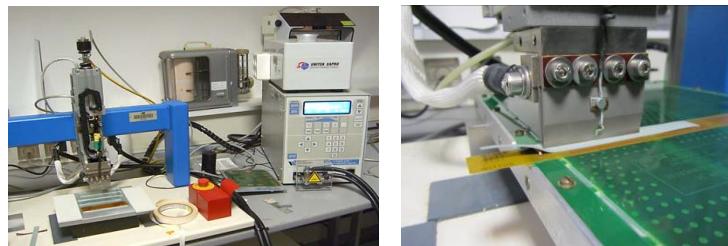
3x FEV8 3C  
4x4 connectors each with 36 channels



Positioning ACF on boards and  
positioning kapton combs

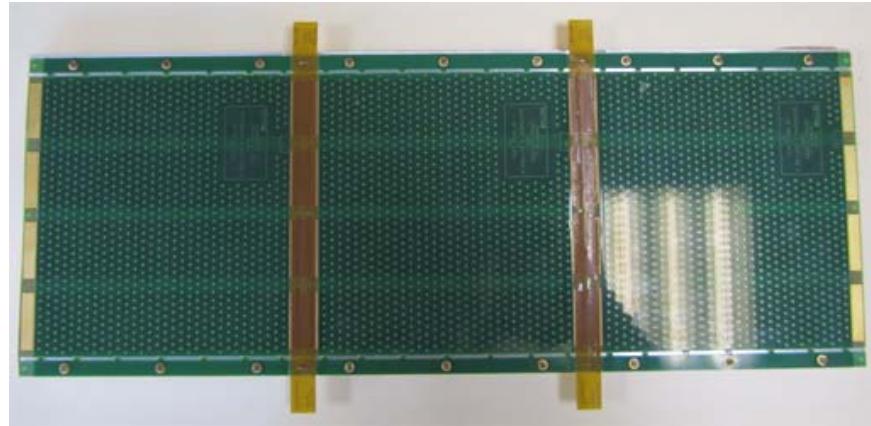


Using Myachi Thermode



Temperature 150°C  
Time 25 seconds  
Pressure 18 Bar

3x FEV8 3C are ready to the electrical test

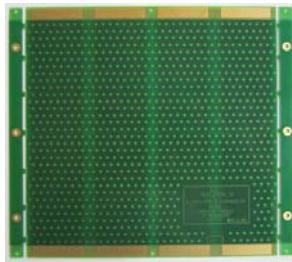


# ASU interconnection with special kapton

FEV8-3C

4 connectors each with 36 channels

Wire  
by  
wire



Kapton combs

4 connectors with 36 copper pads  
**with tin and lead**

length=14mm width=0.5mm

Thickness of copper = 35 $\mu$ m

Thickness of kapton = 50 $\mu$ m

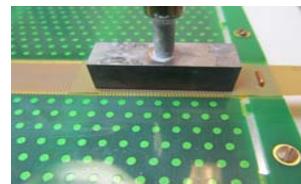
Thickness of tin and lead = 65 $\mu$ m



Using Weller Solder tool



300°C for 5 seconds



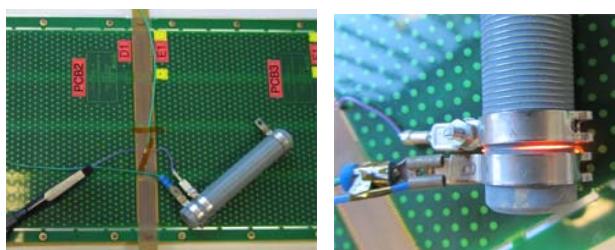
Continuity test



Resistance between wires in PCB = 0.21ohms

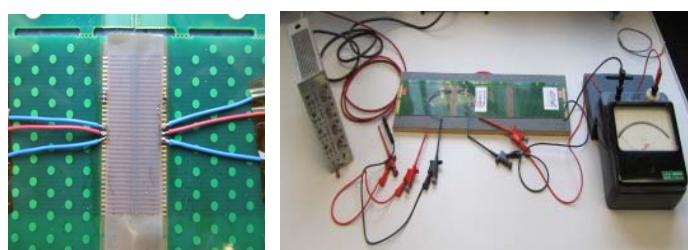
Isolation between wires in PCB =  $\infty$

Power test



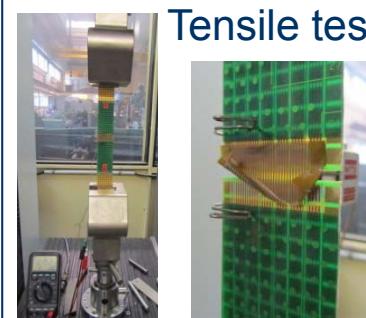
Sfernice adjustable resistance  
 $R = 2.5$  ohms,  $U = 12.8V$ ,  $I = 5A$

HV tests

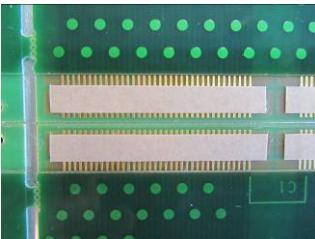


1 wire with Max 1350V  
between 2 ground wires

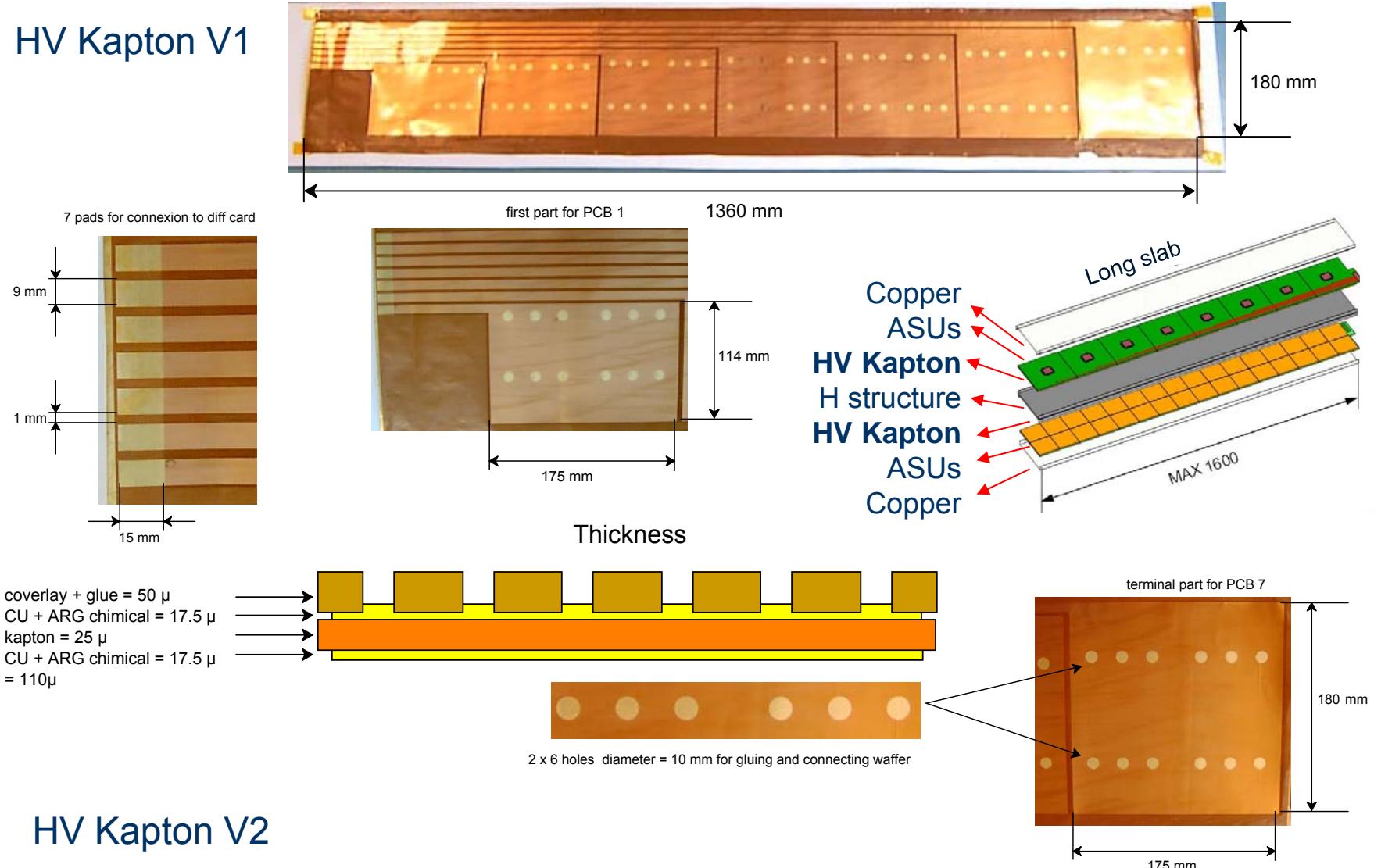
Tensile tests



Max 600N before  
destruction

Technology	Advantages	Disadvantages
N°1 Solder 	-Proven technology -Possible to repair -~3 euros/connector	-Difficult procedure -Too much heat for the glue of wafers -Cannot be industrialized
N°2 ACF 	-Easy to install -Easy to remove -Easy to industrialize	-Needs to have a perfect planarity -Needs to have a thermode ~15Keuros -10mA maximum per wire -~30 euros/connector -Too much pressure =mechanical stress for the wafers
N°3 Spécial Kapton 	-Easy to install -Good reliability -Possible to repair -Easy to industrialize -Good strength -~4 euros/connector	-I don't know yet

## HV Kapton V1



## HV Kapton V2



# Prochaines étapes

## EUDET

- Régler puis tester le manipulateur 3 axes en réalisant l'interconnexion d'une ligne de 7 FEV8 3C.
- Etudier les nouveaux kapton HV pour l'alimentation des wafers.
- Etudier un patch pannel HV avec filtres.
- Réaliser pour les tests beam à Désy en juillet les interconnexions de :  
-8 slabs courts avec chacun 1 FEV8 avec wafers + 1 ADAPT + 1 kapton HV.
- Réaliser pour la fin de l'automne les interconnexions de :  
-1 slab long avec 7 FEV8 avec wafers + 1 ADAPT + kapton HV  
-8 slabs courts avec chacun 1 FEV8 et wafers + 1 ADAPT+ kapton HV.

## ILD

- Etudier l'impact des câbles de tous les sous détecteurs (VTX.FTD.TPC.Hcal.Ecal...) pour l'intégration sur ILD.



Merci pour votre attention